



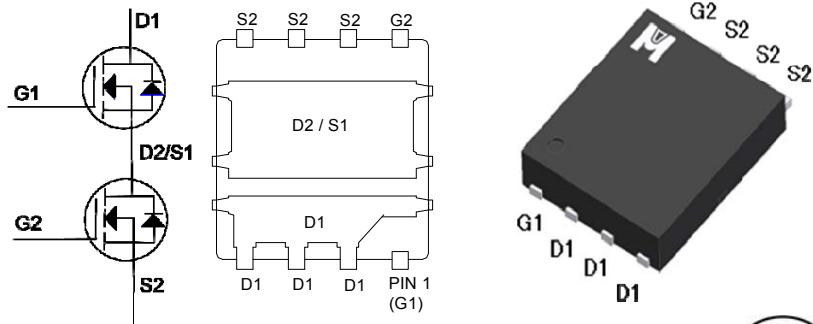
N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

	N-CH-Q1	N-CH-Q2
$BV_{DSS}$	30V	30V
$R_{DS(on)}$ (MAX.)	$5.5\text{m}\Omega$	$2.6\text{m}\Omega$
$I_D$	50A	83A

UIS,  $R_g$  100% Tested

Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS		UNIT
		Q1	Q2	
Gate-Source Voltage	$V_{GS}$	$\pm 20$	$\pm 20$	V
Continuous Drain Current <sup>3</sup>	$I_D$	50	83	A
		31	52	
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	90	150	
Avalanche Current	$I_{AS}$	30	63	
Avalanche Energy	$E_{AS}$	45	198	mJ
Repetitive Avalanche Energy <sup>2</sup>	$E_{AR}$	22	99	
Power Dissipation	$P_D$	48	100	W
		19	40	
Operating Junction & Storage Temperature Range	$T_j, T_{stg}$	-55 to 150		°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL		TYPICAL	MAXIMUM		UNIT
Junction-to-Case	$R_{\theta JC}$	Steady State		2.6	1.25	°C / W
Junction-to-Ambient	$R_{\theta JA}$	Steady State		62	55	
	$R_{\theta JA}$	$t \leq 10\text{s}$		27	24	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle  $\leq 1\%$

<sup>3</sup>Package limitation current, Q1=25A, Q2=36A

$R_{\theta JA}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT	
			MIN	TYP	MAX		
STATIC							
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	Q1	30		V	
			Q2	30			
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	Q1	1	1.5	3	
			Q2	1	1.5	3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$	Q1		$\pm 100$	nA	
			Q2		$\pm 100$		
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 24V, V_{GS} = 0V$	Q1		1	$\mu\text{A}$	
			Q2		1		
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	Q1		25		
			Q2		25		
On-State Drain Current <sup>1</sup>	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	Q1	50		A	
			Q2	83			
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(\text{ON})}$	$V_{GS} = 10V, I_D = 16A$	Q1		4.4	5.5	$\text{m}\Omega$
		$V_{GS} = 10V, I_D = 25A$	Q2		2.2	2.6	
		$V_{GS} = 4.5V, I_D = 10A$	Q1		6.2	8	
		$V_{GS} = 4.5V, I_D = 15A$	Q2		3.0	3.7	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 16A$	Q1		50		S
		$V_{DS} = 5V, I_D = 25A$	Q2		70		
DYNAMIC							
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 15V, f = 1\text{MHz}$	Q1		1508		$\text{pF}$
			Q2		3813		
Output Capacitance	$C_{oss}$		Q1		219		
			Q2		540		
Reverse Transfer Capacitance	$C_{rss}$		Q1		167		
			Q2		440		
Gate Resistance	$R_g$	$V_{GS} = 15\text{mV}, V_{DS} = 0V, f = 1\text{MHz}$	Q1		1.0		$\Omega$
			Q2		1.5		
Total Gate Charge <sup>1,2</sup>	$Q_g(V_{GS}=10V)$	$V_{DD} = 15V, V_{GS} = 10V, I_D = 16A$	Q1		25		$\text{nC}$
			Q2		59		
			Q1		13		
			Q2		28		

Gate-Source Charge <sup>1,2</sup>	$Q_{gs}$	$V_{DD} = 15V, V_{GS} = 10V,$ $I_D = 25A$	Q1		5		
Gate-Drain Charge <sup>1,2</sup>	$Q_{gd}$		Q2		13		
Turn-On Delay Time <sup>1,2</sup>	$t_{d(on)}$	$V_{DD} = 15V,$ $I_D = 1A, V_{GS} = 10V, R_{GS} = 2.7\Omega$	Q1		20		nS
Rise Time <sup>1,2</sup>	$t_r$		Q2		25		
Turn-Off Delay Time <sup>1,2</sup>	$t_{d(off)}$	$I_D = 1A, V_{GS} = 10V, R_{GS} = 2.7\Omega$	Q1		15		
Fall Time <sup>1,2</sup>	$t_f$		Q2		16		
			Q1		55		
			Q2		60		
			Q1		20		
			Q2		25		

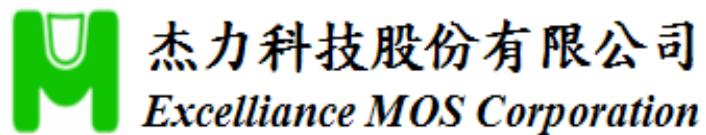
**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_J = 25^\circ C$ )**

Continuous Current	$I_S$	$I_F = 10A, V_{GS} = 0V$	Q1		15		A
Pulsed Current <sup>3</sup>	$I_{SM}$		Q2		25		
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = 16A, dI_F/dt = 100A/\mu S$	Q1		60		V
Reverse Recovery Time	$t_{rr}$		Q2		100		
Reverse Recovery Charge	$Q_{rr}$	$I_F = 25A, dI_F/dt = 100A/\mu S$	Q1		1.2		nS
			Q2		1.2		
		$I_F = 16A, dI_F/dt = 100A/\mu S$	Q1		30		nS
			Q2		35		
		$I_F = 25A, dI_F/dt = 100A/\mu S$	Q1		18		nC
			Q2		25		

<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu sec$ , Duty Cycle  $\leq 2\%$ .

<sup>2</sup>Independent of operating temperature.

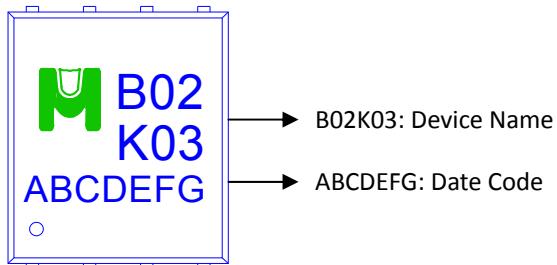
<sup>3</sup>Pulse width limited by maximum junction temperature.



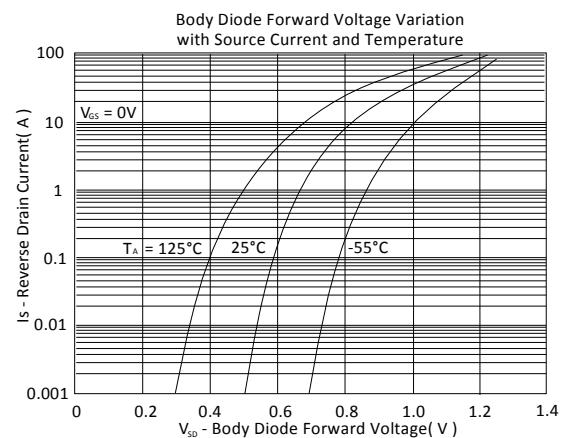
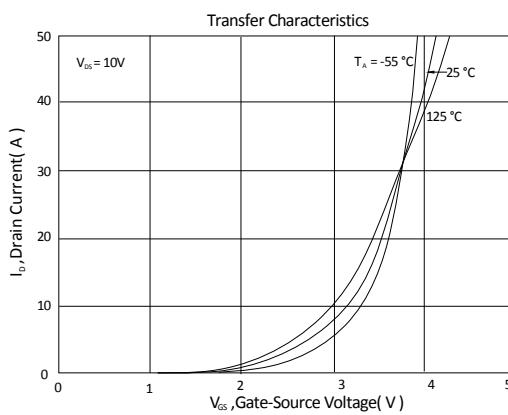
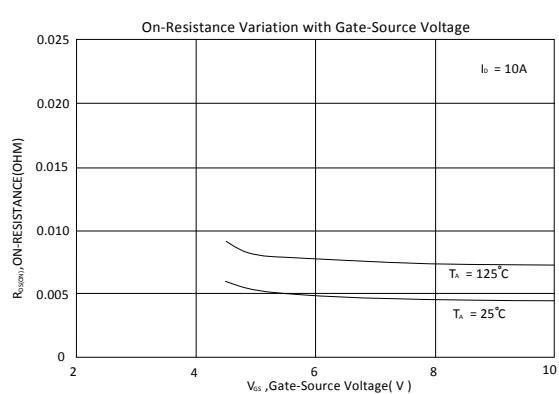
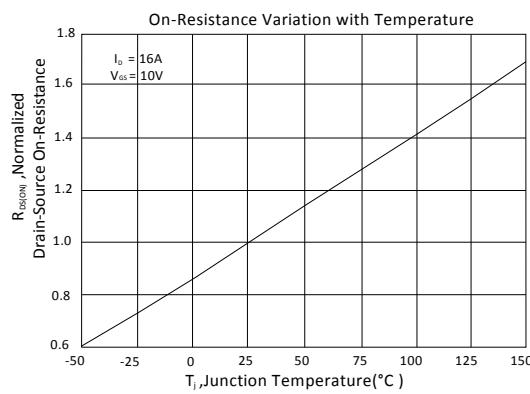
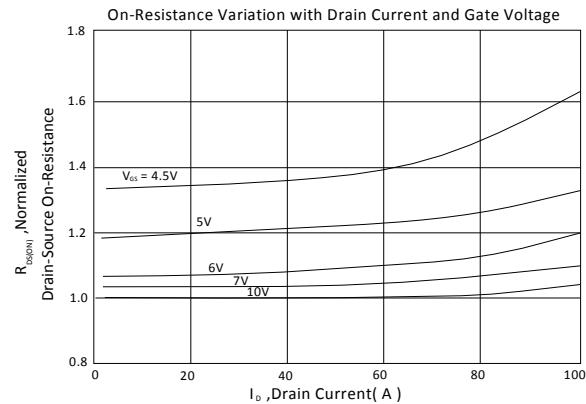
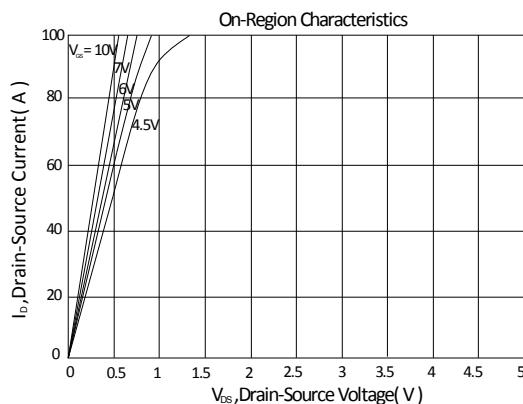
EMB02K03HP

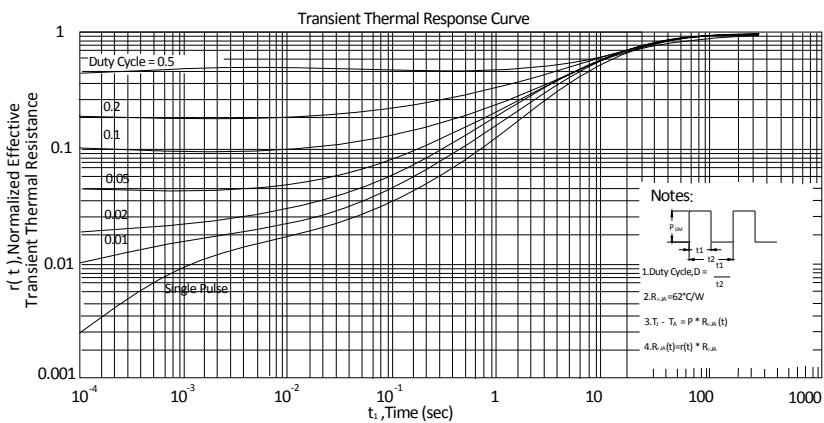
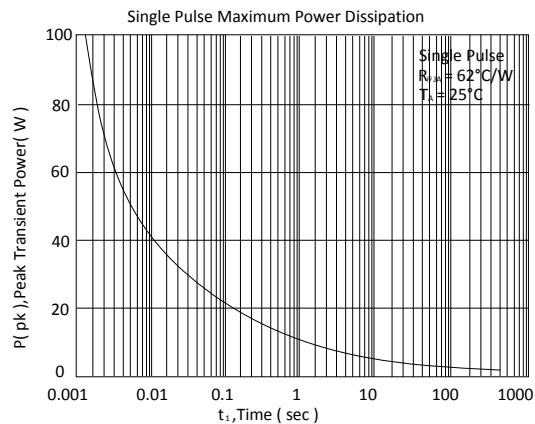
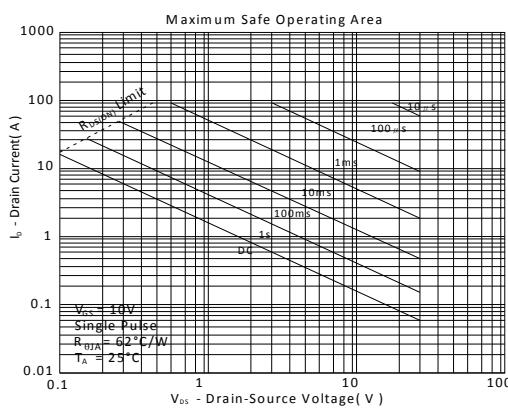
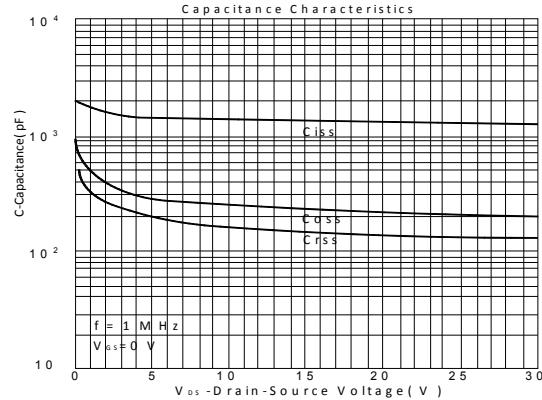
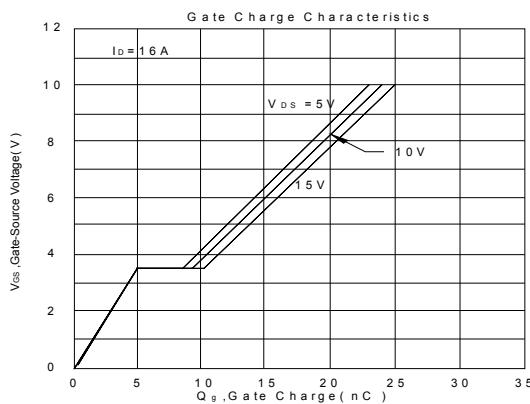
**Ordering & Marking Information:**

Device Name: EMB02K03HP for Asymmetric Dual EDFN 5 x 6

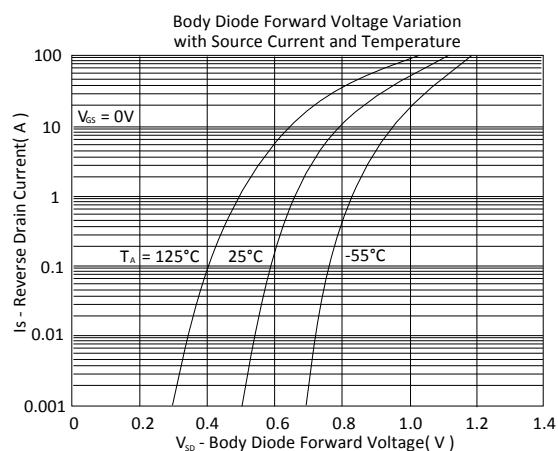
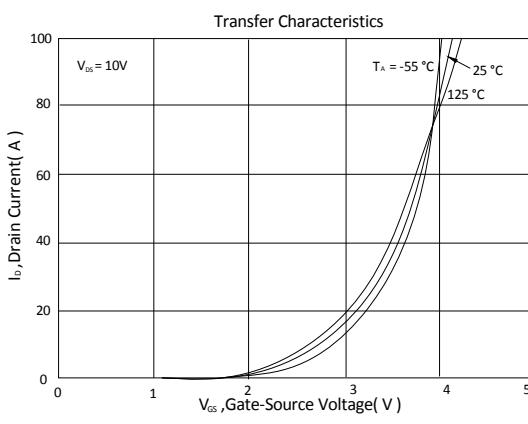
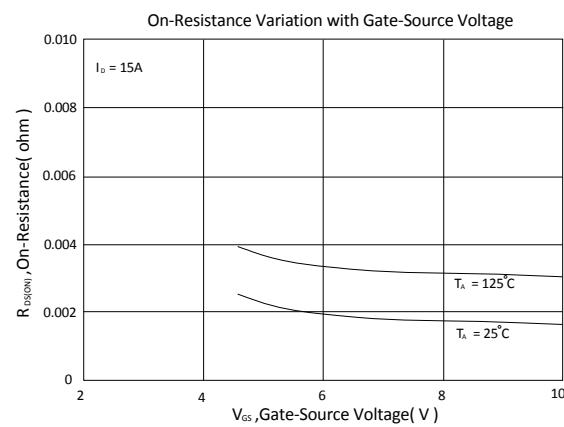
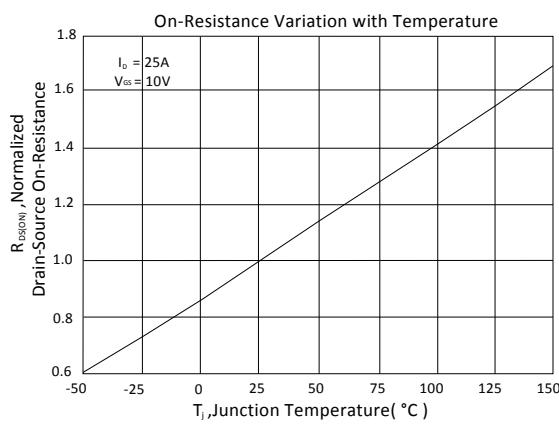
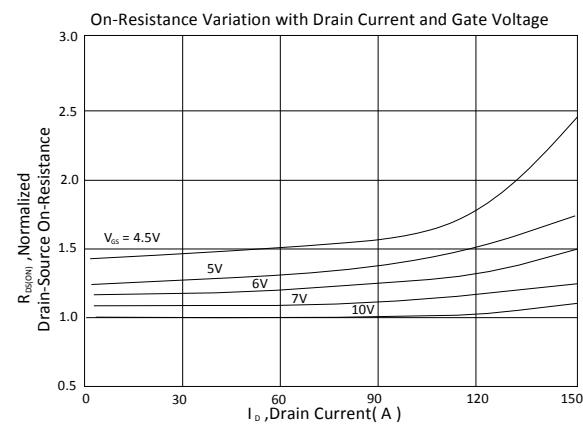
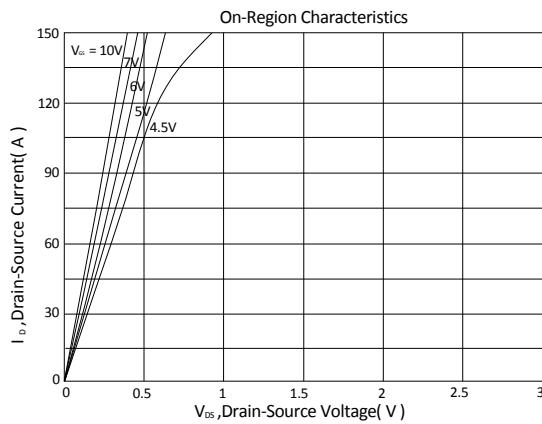


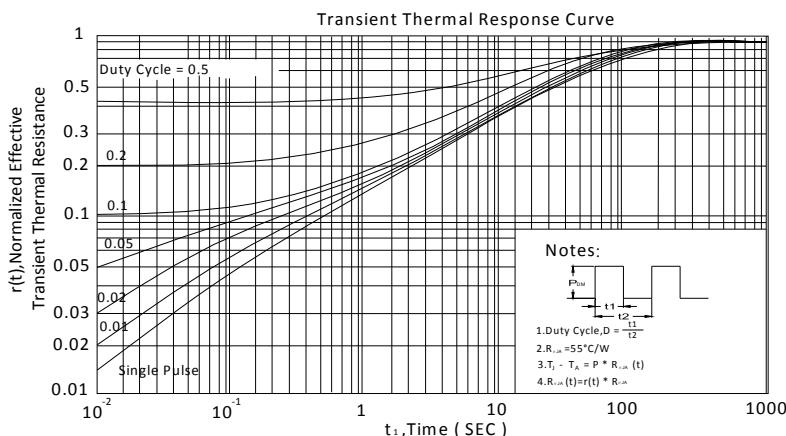
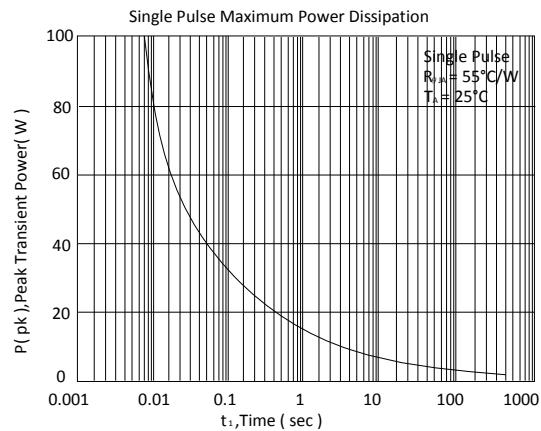
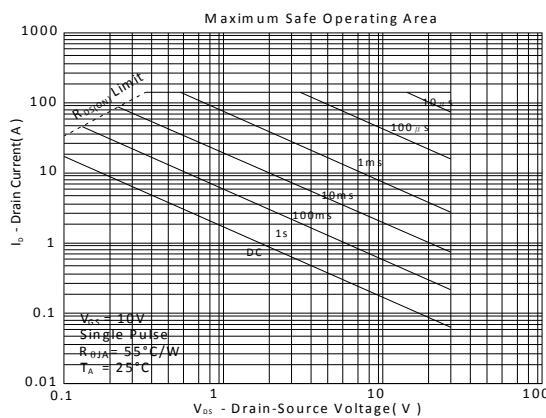
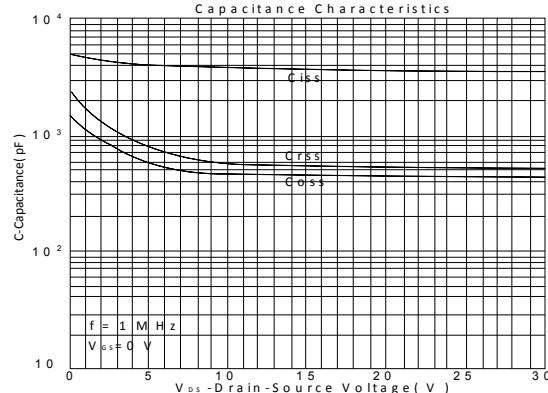
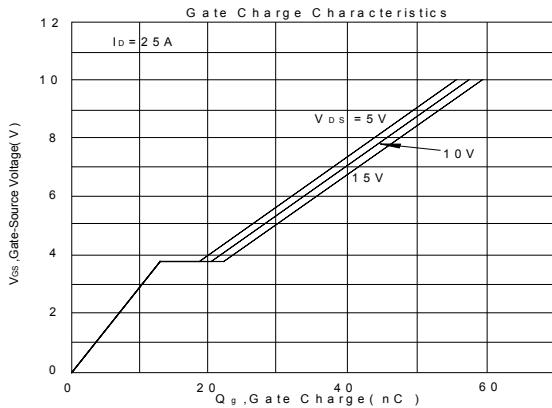
## Q1 TYPICAL CHARACTERISTICS



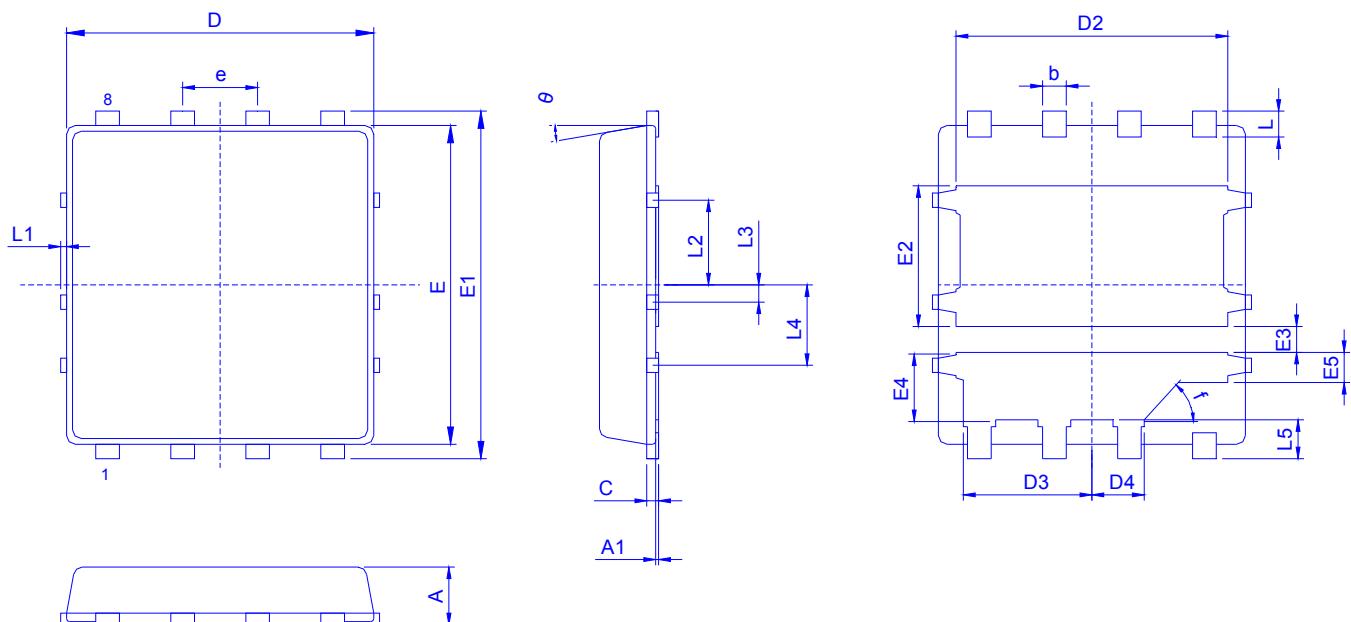


## Q2 TYPICAL CHARACTERISTICS





Outline Drawing



Dimension in mm

Dimension	A	A1	b	c	D	D2	D3	D4	E	E1	E2	E3	E4	E5
Min.	0.85	0.00	0.35	0.15		4.5	2.125	0.835			2.4	0.40	1.125	0.475
Typ.	0.90		0.40	0.20	5.2	4.6	2.175	0.885	5.55	6.05	2.45	0.45	1.175	0.525
Max.	1.00	0.05	0.45	0.25		4.7	2.225	0.935			2.5	0.50	1.225	0.575

Dimension	e	L	L1	L2	L3	L4	L5	F	θ
Min.		0.35	0	1.375	0.2	1.3	0.575		0°
Typ.	1.27	0.45		1.475	0.3	1.4	0.675	45°	
Max.		0.55	0.1	1.575	0.4	1.5	0.775		10°

Recommended minimum pads

